

CX-3V-SM CRYSTAL

18 kHz to 600 kHz Miniature Surface Mount Quartz Crystal for Pierce Oscillators

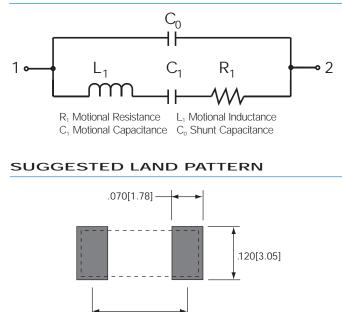
DESCRIPTION

The CX-3V-SM quartz crystals are leadless devices designed for surface mounting on printed circuit boards or hybrid substrates. These miniature crystals are intended to be used in Pierce oscillators. They are hermetically sealed in a rugged, miniature ceramic package. They are manufactured using the STATEKdeveloped photolithographic process, and were designed utilizing the experience acquired by producing millions of crystals for industrial, commercial, military and medical applications. Maximum process temperature should not exceed 260°C.

FEATURES

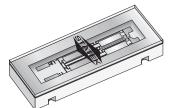
- Miniature tuning fork design
- High shock resistance
- Designed for low power applications
- Compatible with hybrid or PC board packaging
- Low aging
- Full military testing available
- Ideal for battery operated applications
- Designed and manufactured in the USA

EQUIVALENT CIRCUIT



.215[5.46]

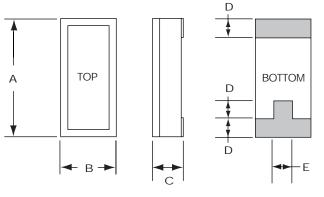
INCHES[mm]



actual size

side view

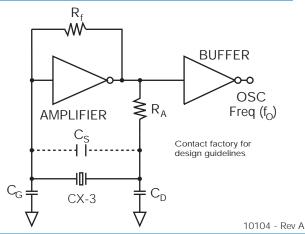
PACKAGE DIMENSIONS



	TYP.		MA	Х.	
DIM	INCHES	mm	INCHES	mm	
А	.265	6.73	.280	7.11	
В	.103	2.62	.114	2.90	
С	-	-	see	below	
D	.050	1.27	.060	1.52	
E	.052	1.32	.062	1.57	

DIM "C""	GLASS	LID	CERAMIC	LID
MAX	INCHES	mm	INCHES	mm
SM1	.058	1.47	.069	1.75
SM2	.060	1.52	.071	1.80
SM3	.063	1.60	.074	1.88

CONVENTIONAL CMOS PIERCE OSCILLATOR CIRCUIT





SPECIFICATIONS

Specifications are typical at 25°C	C unless otherwise noted.
Specifications are subject to char	nae without notice

Specifications are subject to	change without notice.
Frequency Range	<u>18 kHz to 600 kHz</u>
Functional Mode	Tuning Fork (Flexure)
Calibration Tolerance*	A, B or C
(see below)	
Motional Resistance (R1)	See Figure 1
	MAX.: 18-25 kHz, 2x Typ.
	25-600 kHz, 2.5x Typ.
Motional Capacitance (C1)	Figure 2
Quality Factor (Q)	Figure 3
	Min. is 0.25x Typ.
Shunt Capacitance (C ₀)	1.8 pF MAX.
Drive Level	18-25 kHz 0.5 μW MAX.
	25-600 kHz 1.0 μW MAX.
Turning Point (T ₀)**	Figure 4
Temperature Coefficient (k)	-0.035 ppm/°C ²
Aging, first year	5ppm MAX.
Shock***	1,500g peak, 0.3 msec., 1/2 sine
Vibration, survival***	10g rms, 20-2,000 Hz random
Operating Temperature	-10°C to +70°C Commercial
	-40°C to +85°C Industrial
	-55°C to +125°C Military
Storage Temperature	-55°C to +125°C
Max Process Temperature	260° C for 20 sec

Max Process Temperature 260°C for 20 sec.

* Tighter frequency calibration available.

** Other turning point available.

*** Higher shock and vibration available.

CX-3V Crystal Calibration Tolerance at 25°C

	Freq	uency Range	e (kHz)	
Calibration	18-74.9	75-169.9	170-249.9	250-600
А	± 0.003%	± 0.005%	± 0.01%	±0.02%
В	± 0.01%	± 0.01%	± 0.02%	±0.05%
С	± 0.1%	± 0.1%	⁺ 0.2%	± 0.5%

*** Other calibration values available, consult factory.

Load Capacitance (CL), Used to Calibrate CX-3V (other CL available)

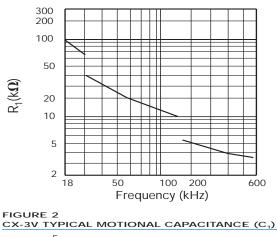
Frequency Range (kHz)	Load Capacitance (pF)	Frequency Range (kHz)	Load Capacitance (pF)
18-24.9	10	100.1-179.9	5
25-54.9	9	180-600	4
55-100.0	8		

HOW TO ORDER CX-3V-SM CRYSTALS

CX-3V		-SM1	32.768	kHz (<u>A</u>	/)
"S" if special or custom design. Blank if Std.		SM1 SM2 SM3 < = Glass Li eramic Lid	Frequency	Calibration Tolerance* @ 25°C (A) (B) (C)	Temp. Range: C = Commercial I = Industrial M = Military S = Specify
*Other calibration fi	ll in nnm				

*Other calibration fill in ppm.

FIGURE 1 CX-3V TYPICAL MOTIONAL RESISTANCE (R1)



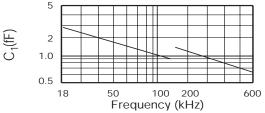


FIGURE 3

CX-3V TYPICAL QUALITY FACTOR (Q)

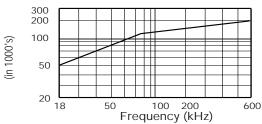
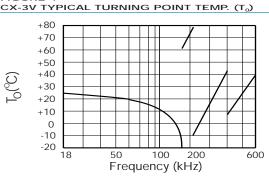


FIGURE 4





$$\frac{\text{f-f}_{\text{O}}}{\text{f}_{\text{O}}} = \text{k(T-T_{\text{O}})}^2$$

TERMINATIONS

Designation	<u>Termination</u>
SM1	Gold Plated
SM2	Nickel, Solder Plated
SM3	Nickel, Solder Plated and Solder Dipped

PACKAGING

CX-3V-SM - Tray Pack (Standard)

-16mm tape, 7" or 13" reels (Optional) Per EIA 481 (see data sheet 10109)

10104 - Rev A

